

# HAT2210R, HAT2210RJ

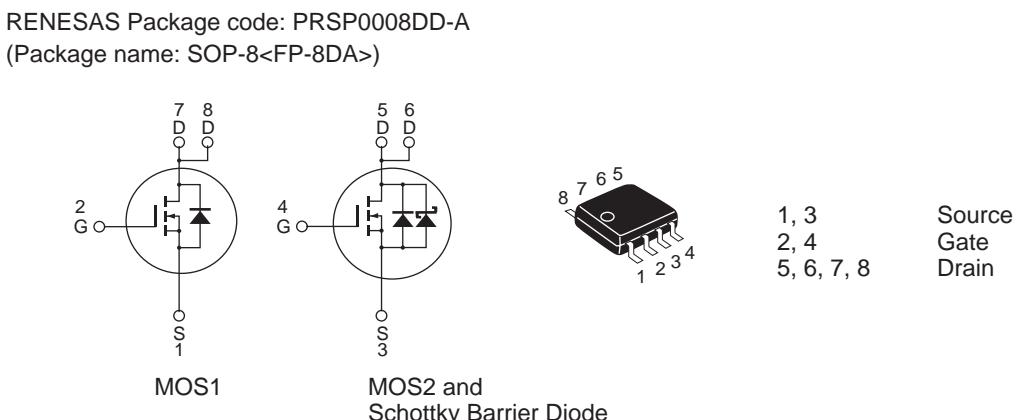
# Silicon N Channel Power MOS FET with Schottky Barrier Diode High Speed Power Switching

REJ03G0578-0300  
Rev.3.00  
Mar.15.2005

## Features

- Low on-resistance
  - Capable of 4.5 V gate drive
  - High density mounting
  - Built-in Schottky Barrier Diode

## Outline



## Absolute Maximum Ratings

(Ta = 25°C)

| Item                    | Symbol                                  | Ratings     |             |             |             | Unit |  |
|-------------------------|---|-------------|-------------|-------------|-------------|------|--|
|                         |   | HAT2210R    |             | HAT2210RJ   |             |      |  |
|                         |   | MOS1        | MOS2 & SBD  | MOS1        | MOS2 & SBD  |      |  |
| Drain to source voltage | V <sub>DSS</sub>                        | 30          | 30          | 30          | 30          | V    |  |
| Gate to source voltage  | V <sub>GSS</sub>                        | ±20         | ±12         | ±20         | ±12         | V    |  |
| Drain current           | I <sub>D</sub>                          | 7.5         | 8.0         | 7.5         | 8.0         | A    |  |
| Drain peak current      | I <sub>D(pulse)</sub> <sup>Note 1</sup> | 60          | 64          | 60          | 64          | A    |  |
| Reverse drain current   | I <sub>DR</sub>                         | 7.5         | 8.0         | 7.5         | 8.0         | A    |  |
| Avalanche current       | I <sub>AP</sub> <sup>Note 2</sup>       | —           | —           | 7.5         | 8.0         | A    |  |
| Avalanche energy        | E <sub>AR</sub> <sup>Note 2</sup>       | —           | —           | 5.62        | 6.4         | mJ   |  |
| Channel dissipation     | P <sub>ch</sub> <sup>Note 3</sup>       | 1.5         | 1.5         | 1.5         | 1.5         | W    |  |
| Channel temperature     | T <sub>ch</sub>                         | 150         | 150         | 150         | 150         | °C   |  |
| Storage temperature     | T <sub>stg</sub>                        | −55 to +150 | −55 to +150 | −55 to +150 | −55 to +150 | °C   |  |

Notes: 1. PW  $\leq$  10  $\mu$ s, duty cycle  $\leq$  1 %

## 2. Value at $T_{ch} = 25^\circ\text{C}$ , $R_g \geq 50 \Omega$

3. 1 Drive operation; When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW ≤ 10 s

## Electrical Characteristics

- MOS1

(Ta = 25°C)

| Item  | Symbol               | Min              | Typ  | Max  | Unit | Test Conditions  |
|---|----------------------|------------------|------|------|------|--|
| Drain to source breakdown voltage             | V <sub>(BR)DSS</sub> | 30               | —    | —    | V    | I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0  |
| Gate to source leak current                   | I <sub>GSS</sub>     | —                | —    | ±0.1 | μA   | V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0   |
| Zero gate voltage drain current               | I <sub>DSS</sub>     | —                | —    | 1    | μA   | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0  |
| Zero gate voltage<br>drain current            | HAT2210R             | I <sub>DSS</sub> | —    | —    | μA   | V <sub>DS</sub> = 24 V, V <sub>GS</sub> = 0,<br>Ta = 125°C   |
|   | HAT2210RJ            | I <sub>DSS</sub> | —    | 10   | μA   |  |
| Gate to source cutoff voltage                 | V <sub>GS(off)</sub> | 1.0              | —    | 2.5  | V    | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA  |
| Static drain to source on state<br>resistance | R <sub>DS(on)</sub>  | —                | 19   | 24   | mΩ   | I <sub>D</sub> = 3.75 A, V <sub>GS</sub> = 10 V <sup>Note4</sup>   |
|   | R <sub>DS(on)</sub>  | —                | 27   | 40   | mΩ   | I <sub>D</sub> = 3.75 A, V <sub>GS</sub> = 4.5 V <sup>Note4</sup>  |
| Forward transfer admittance                   | y <sub>fs</sub>      | 9                | 15   | —    | S    | I <sub>D</sub> = 3.75 A, V <sub>DS</sub> = 10 V <sup>Note4</sup>   |
| Input capacitance                             | C <sub>iss</sub>     | —                | 630  | —    | pF   | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0,<br>f = 1MHz   |
| Output capacitance                            | C <sub>oss</sub>     | —                | 155  | —    | pF   |  |
| Reverse transfer capacitance                  | C <sub>rss</sub>     | —                | 57   | —    | pF   |  |
| Total gate charge                             | Q <sub>g</sub>       | —                | 4.6  | —    | nC   | V <sub>DD</sub> = 10 V, V <sub>GS</sub> = 4.5 V,<br>I <sub>D</sub> = 7.5 A   |
| Gate to source charge                         | Q <sub>gs</sub>      | —                | 2.2  | —    | nC   |  |
| Gate to drain charge                          | Q <sub>gd</sub>      | —                | 1.2  | —    | nC   |  |
| Turn-on delay time                            | t <sub>d(on)</sub>   | —                | 7    | —    | ns   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.75 A,<br>V <sub>DD</sub> ≈ 10 V, R <sub>L</sub> = 2.66 Ω,<br>R <sub>g</sub> = 4.7 Ω |
| Rise time                                     | t <sub>r</sub>       | —                | 14   | —    | ns   |  |
| Turn-off delay time                           | t <sub>d(off)</sub>  | —                | 36   | —    | ns   |  |
| Fall time                                     | t <sub>f</sub>       | —                | 3.4  | —    | ns   |  |
| Body-drain diode forward voltage              | V <sub>DF</sub>      | —                | 0.85 | 1.11 | V    | IF = 7.5 A, V <sub>GS</sub> = 0 <sup>Note4</sup>   |
| Body-drain diode reverse<br>recovery time     | t <sub>rr</sub>      | —                | 17   | —    | ns   | IF = 7.5 A, V <sub>GS</sub> = 0<br>dI/F/dt = 100 A/μs  |

Notes: 4. Pulse test

- MOS2 & Schottky Barrier Diode

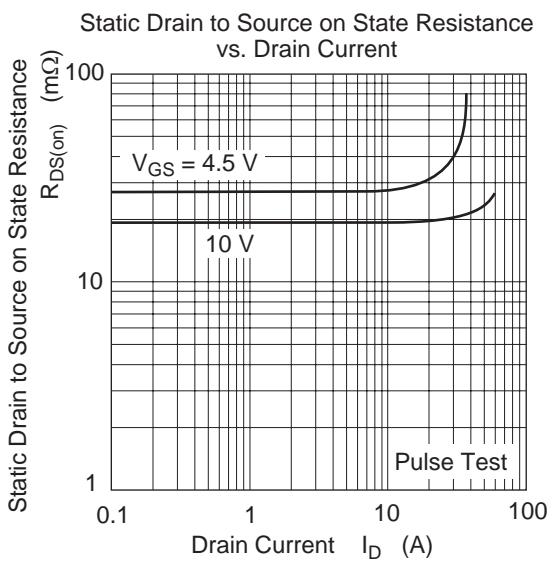
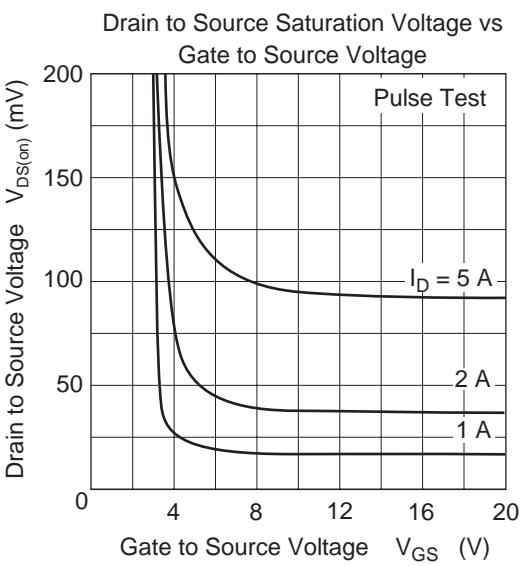
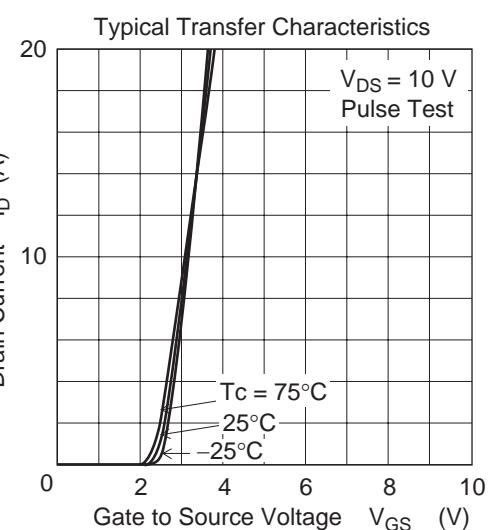
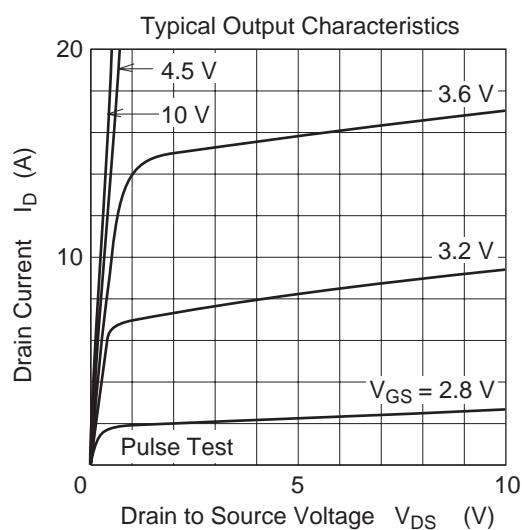
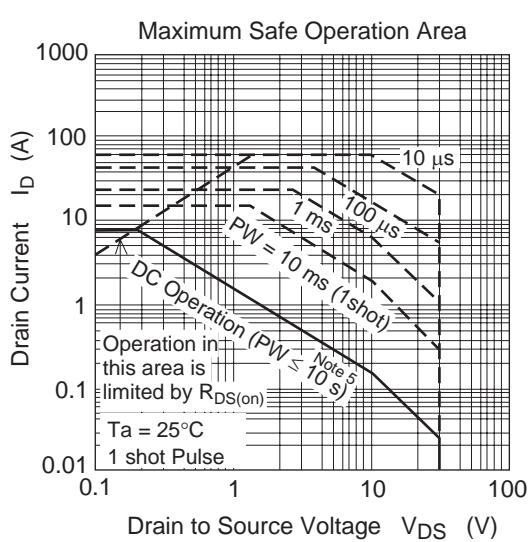
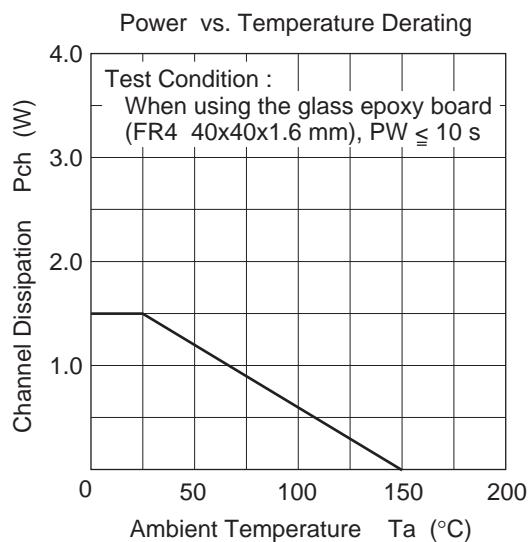
(Ta = 25°C)

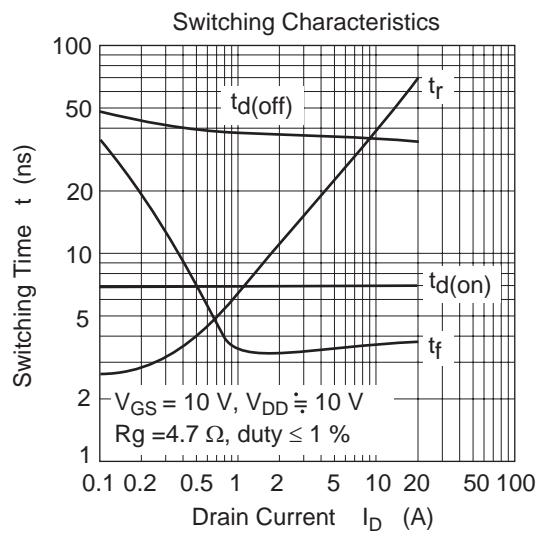
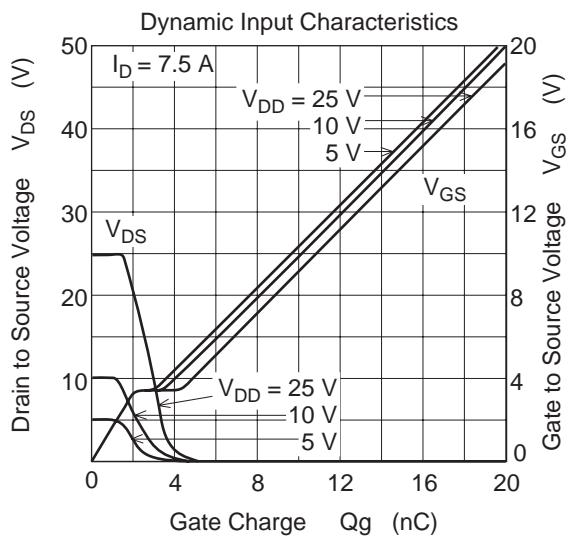
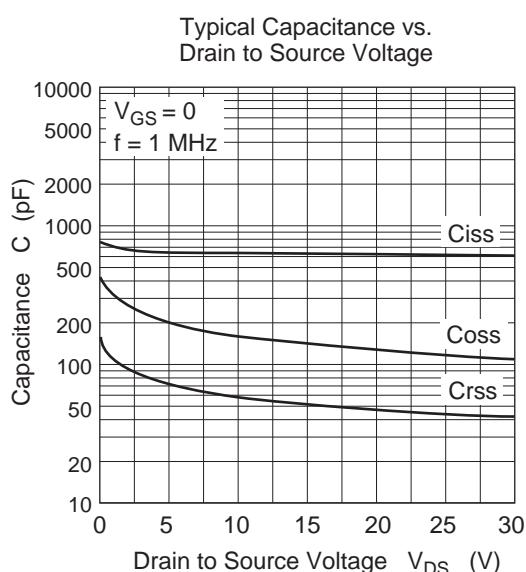
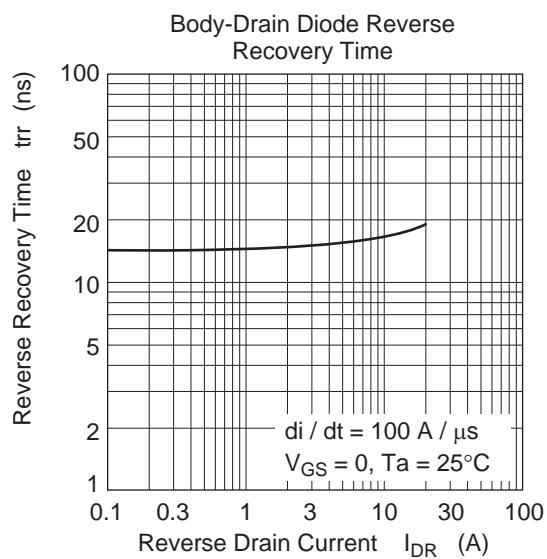
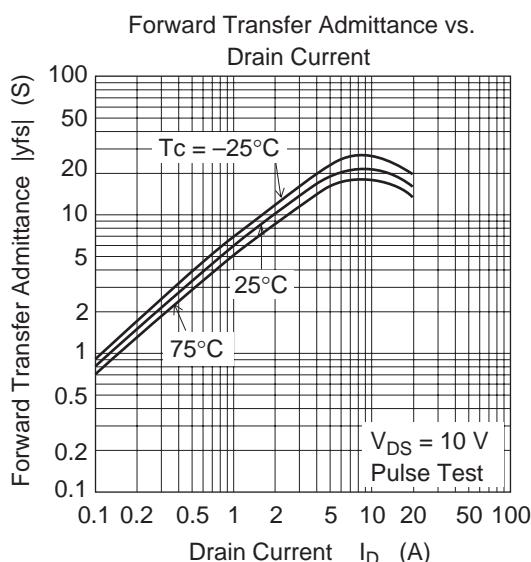
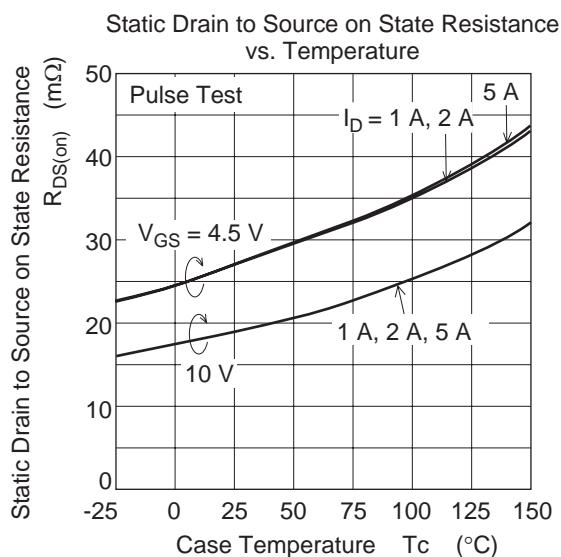
| Item                                       | Symbol               | Min | Typ  | Max  | Unit | Test Conditions  |
|--|----------------------|-----|------|------|------|--|
| Drain to source breakdown voltage          | V <sub>(BR)DSS</sub> | 30  | —    | —    | V    | I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0  |
| Gate to source leak current                | I <sub>GSS</sub>     | —   | —    | ±0.1 | μA   | V <sub>GS</sub> = ±12 V, V <sub>DS</sub> = 0   |
| Zero gate voltage drain current            | I <sub>DSS</sub>     | —   | —    | 1    | mA   | V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0  |
| Gate to source cutoff voltage              | V <sub>GS(off)</sub> | 1.4 | —    | 2.5  | V    | V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA  |
| Static drain to source on state resistance | R <sub>DS(on)</sub>  | —   | 17   | 22   | mΩ   | I <sub>D</sub> = 4 A, V <sub>GS</sub> = 10 V <sup>Note4</sup>  |
|  | R <sub>DS(on)</sub>  | —   | 21   | 29   | mΩ   | I <sub>D</sub> = 4 A, V <sub>GS</sub> = 4.5 V <sup>Note4</sup>   |
| Forward transfer admittance                | y <sub>fs</sub>      | 15  | 25   | —    | S    | I <sub>D</sub> = 4 A, V <sub>DS</sub> = 10 V <sup>Note4</sup>  |
| Input capacitance                          | C <sub>iss</sub>     | —   | 1330 | —    | pF   | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0,<br>f = 1MHz   |
| Output capacitance                         | C <sub>oss</sub>     | —   | 230  | —    | pF   |  |
| Reverse transfer capacitance               | C <sub>rss</sub>     | —   | 92   | —    | pF   |  |
| Total gate charge                          | Q <sub>g</sub>       | —   | 11   | —    | nC   | V <sub>DD</sub> = 10 V, V <sub>GS</sub> = 4.5 V,<br>I <sub>D</sub> = 8 A   |
| Gate to source charge                      | Q <sub>gs</sub>      | —   | 3.8  | —    | nC   |  |
| Gate to drain charge                       | Q <sub>gd</sub>      | —   | 3.2  | —    | nC   |  |
| Turn-on delay time                         | t <sub>d(on)</sub>   | —   | 10   | —    | ns   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4 A,<br>V <sub>DD</sub> ≈ 10 V, R <sub>L</sub> = 2.5 Ω,<br>R <sub>g</sub> = 4.7 Ω |
| Rise time                                  | t <sub>r</sub>       | —   | 16   | —    | ns   |  |
| Turn-off delay time                        | t <sub>d(off)</sub>  | —   | 43   | —    | ns   |  |
| Fall time                                  | t <sub>f</sub>       | —   | 3.9  | —    | ns   |  |
| Schottky Barrier diode forward voltage     | V <sub>F</sub>       | —   | 0.5  | —    | V    | I <sub>F</sub> = 3.5 A, V <sub>GS</sub> = 0 <sup>Note4</sup>   |
| Body-drain diode reverse recovery time     | t <sub>rr</sub>      | —   | 15   | —    | ns   | I <sub>F</sub> = 8 A, V <sub>GS</sub> = 0<br>dI <sub>F</sub> /dt = 100 A/μs  |

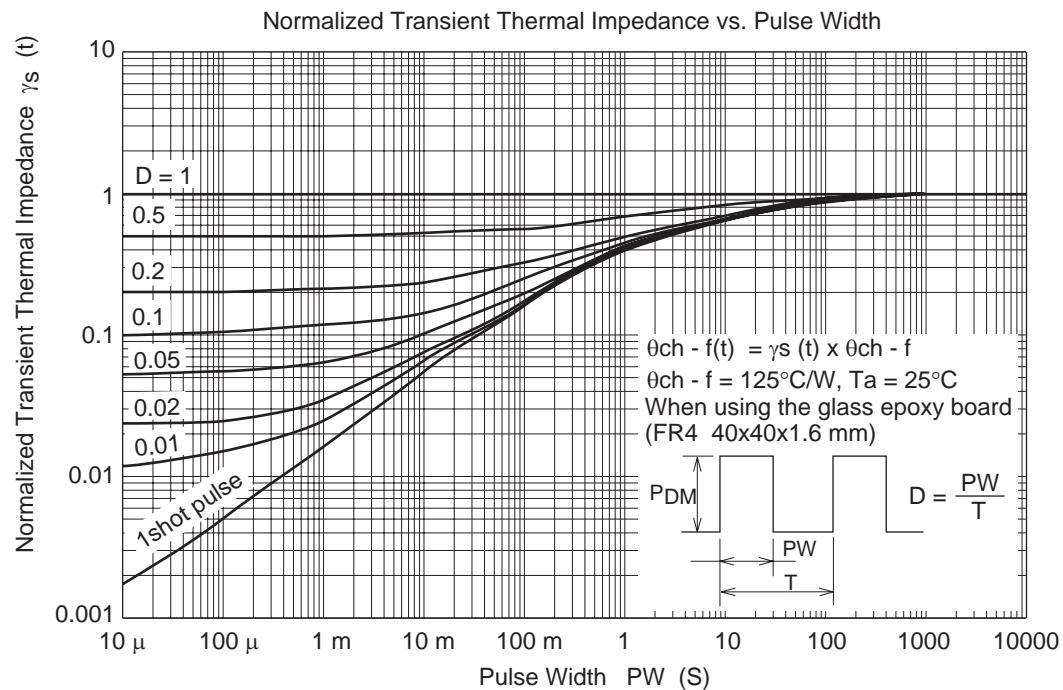
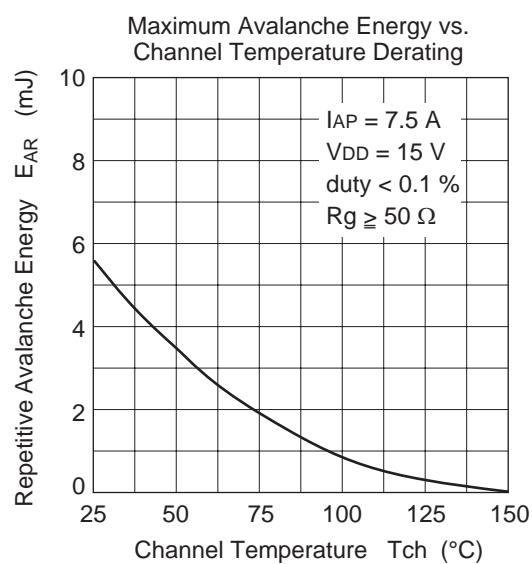
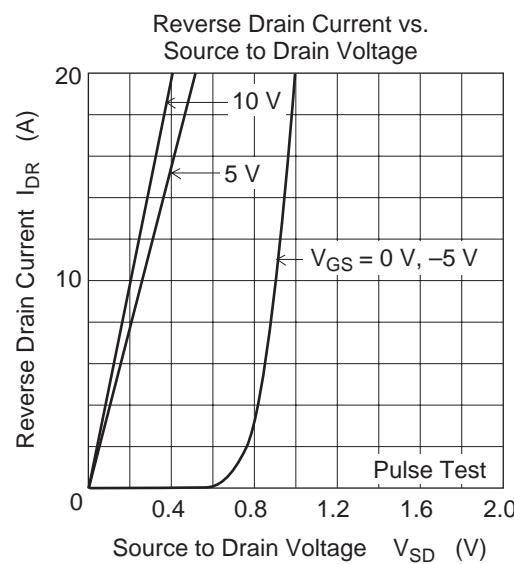
Notes: 4. Pulse test

## Main Characteristics

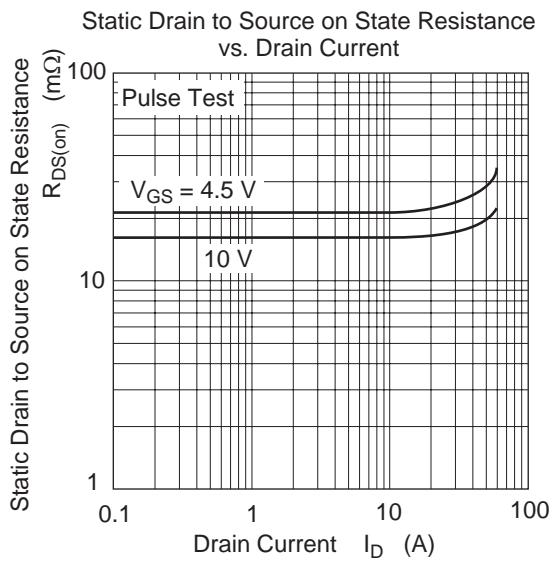
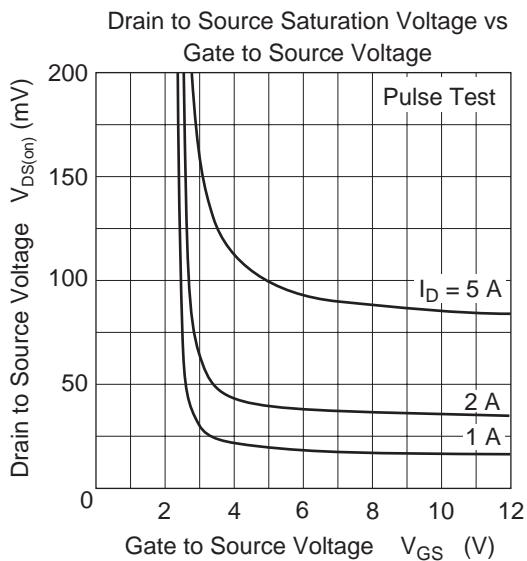
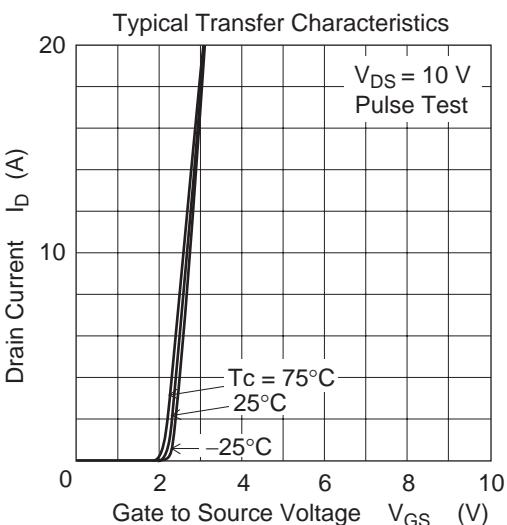
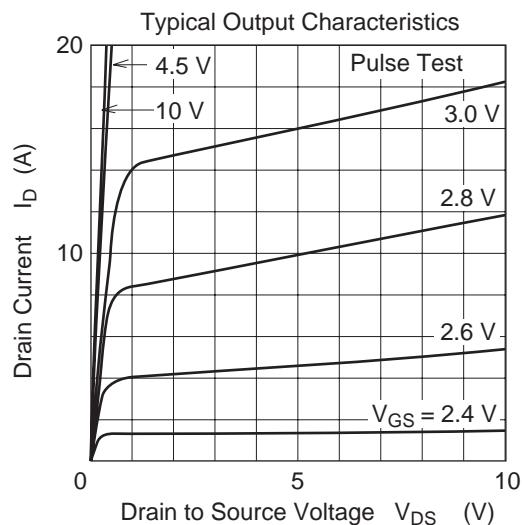
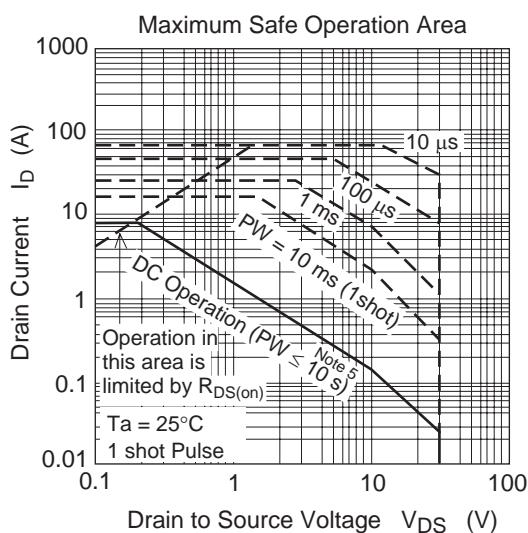
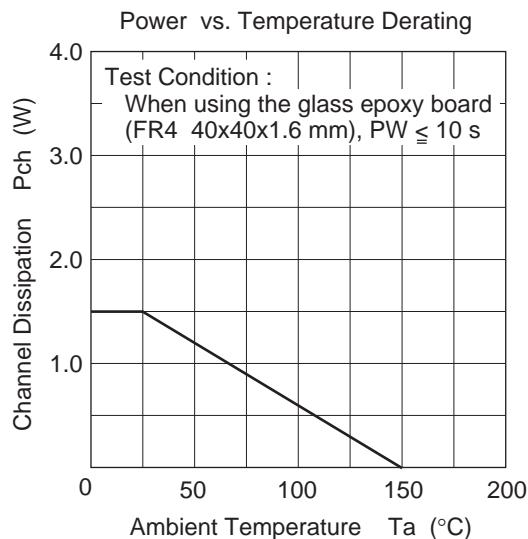
- MOS1

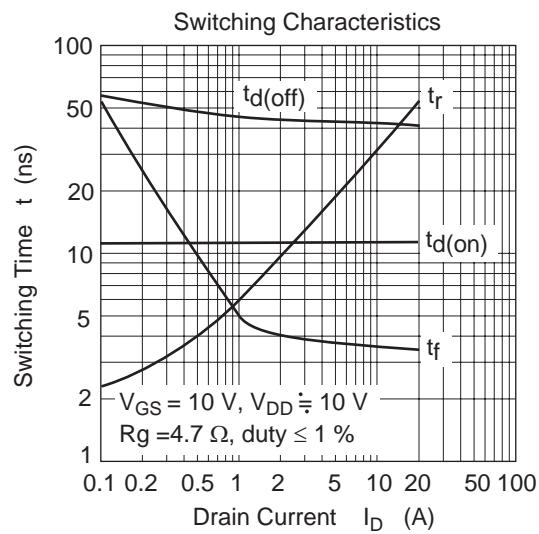
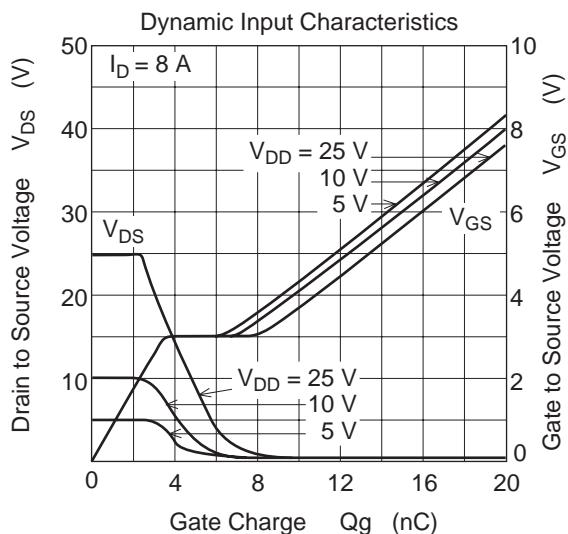
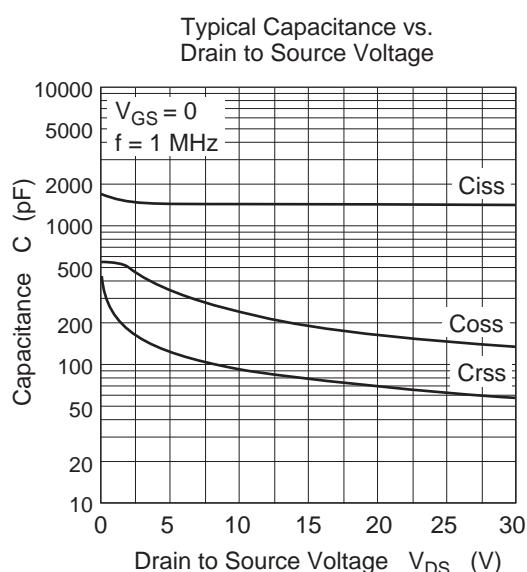
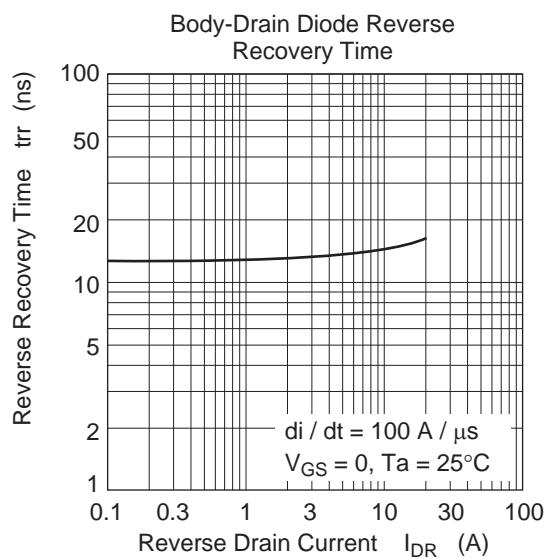
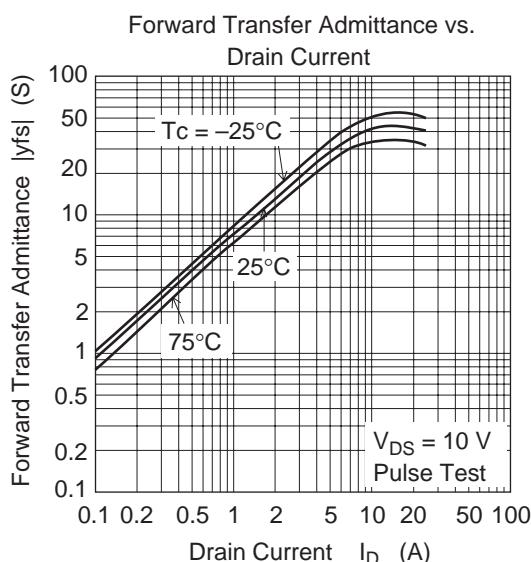
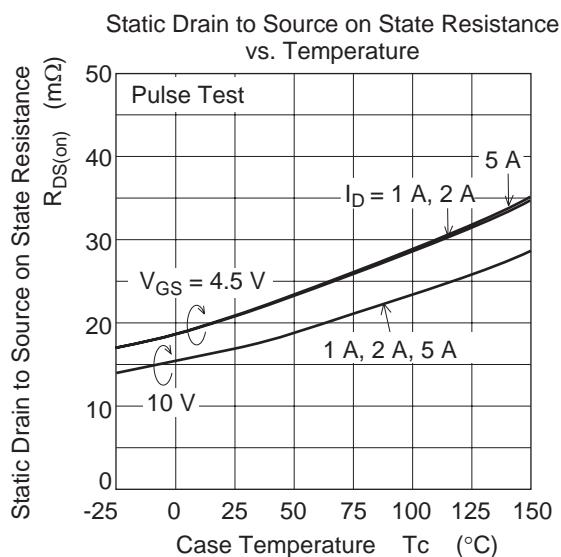


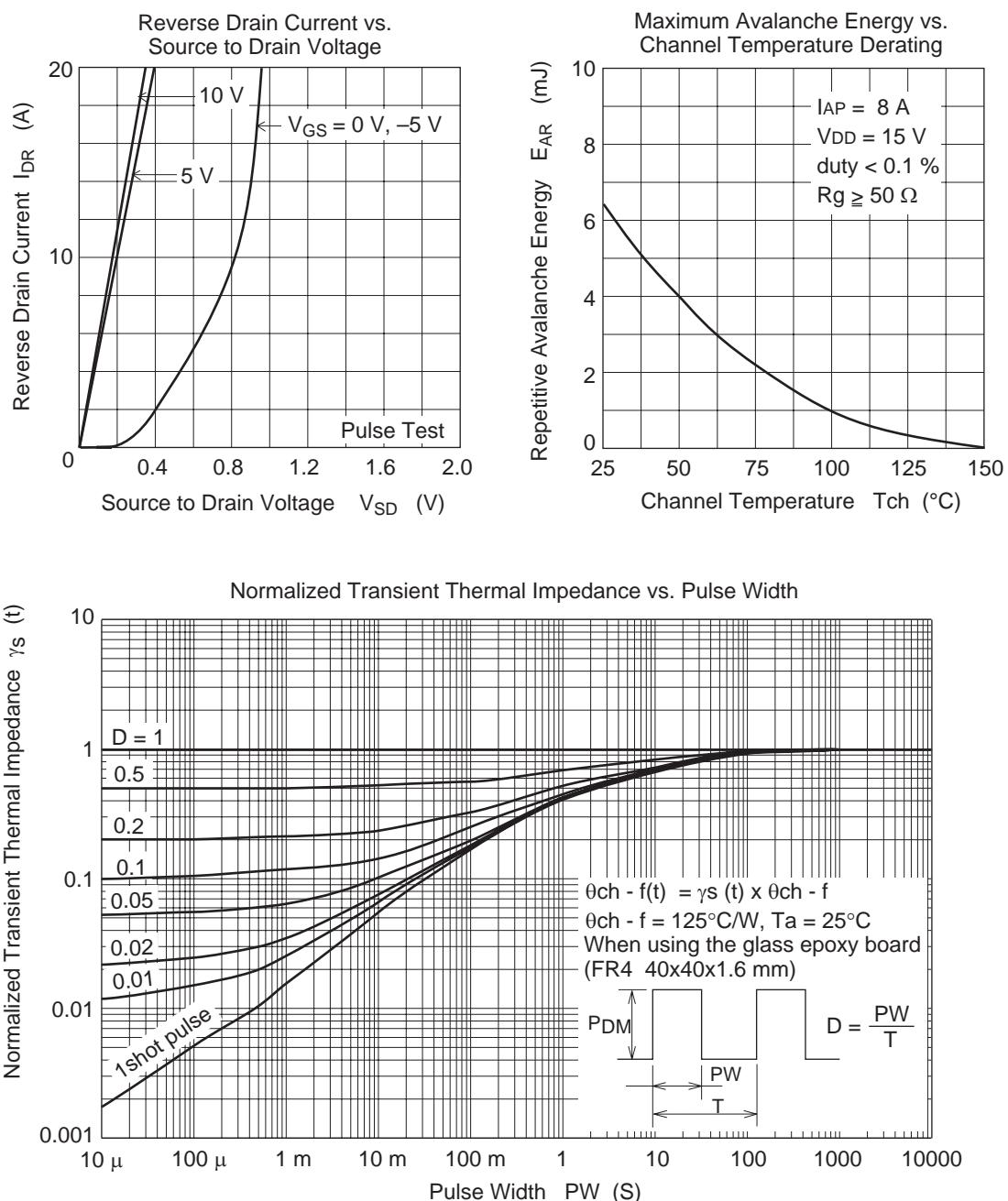




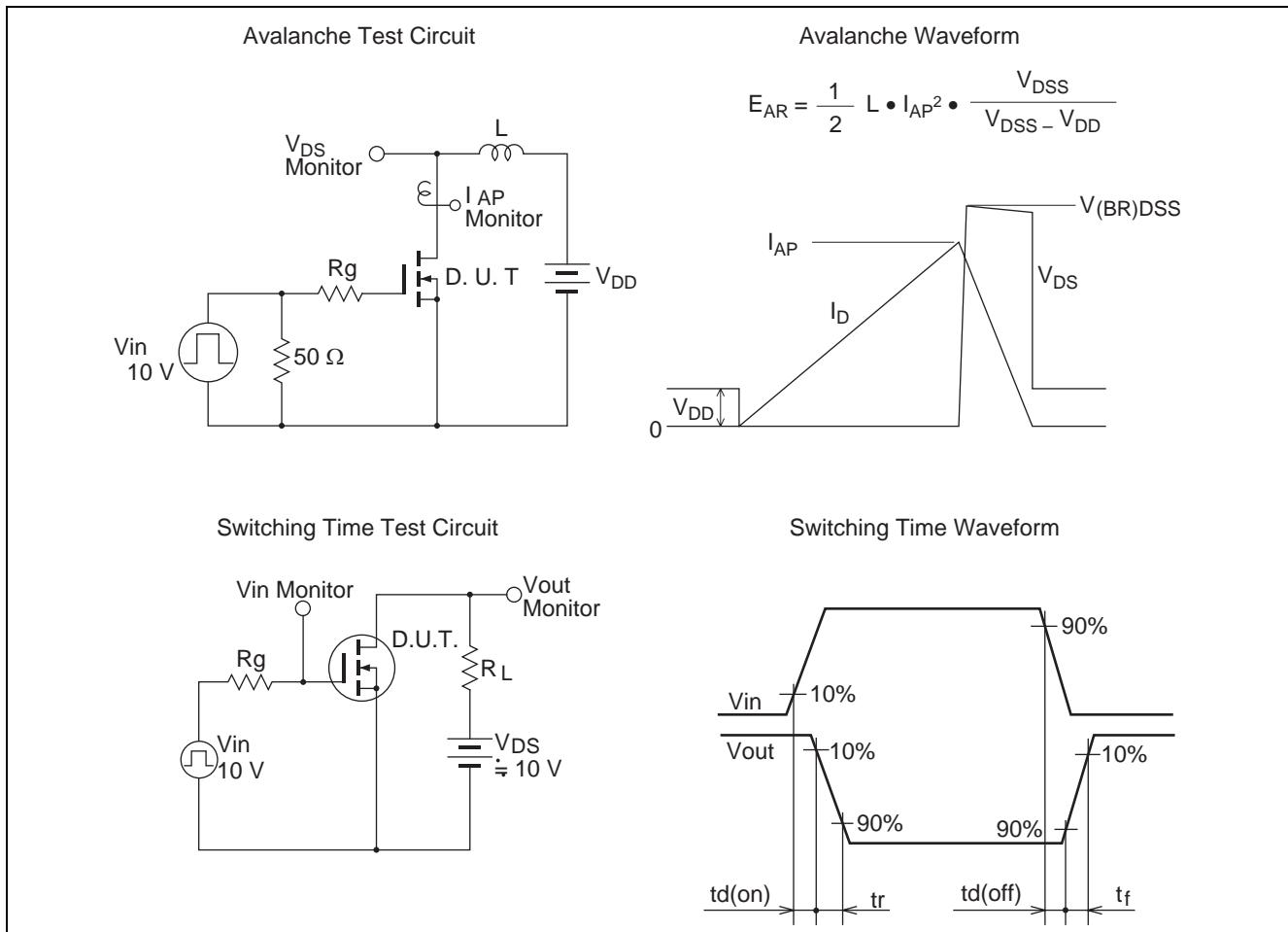
• MOS2 & Schottky Barrier Diode



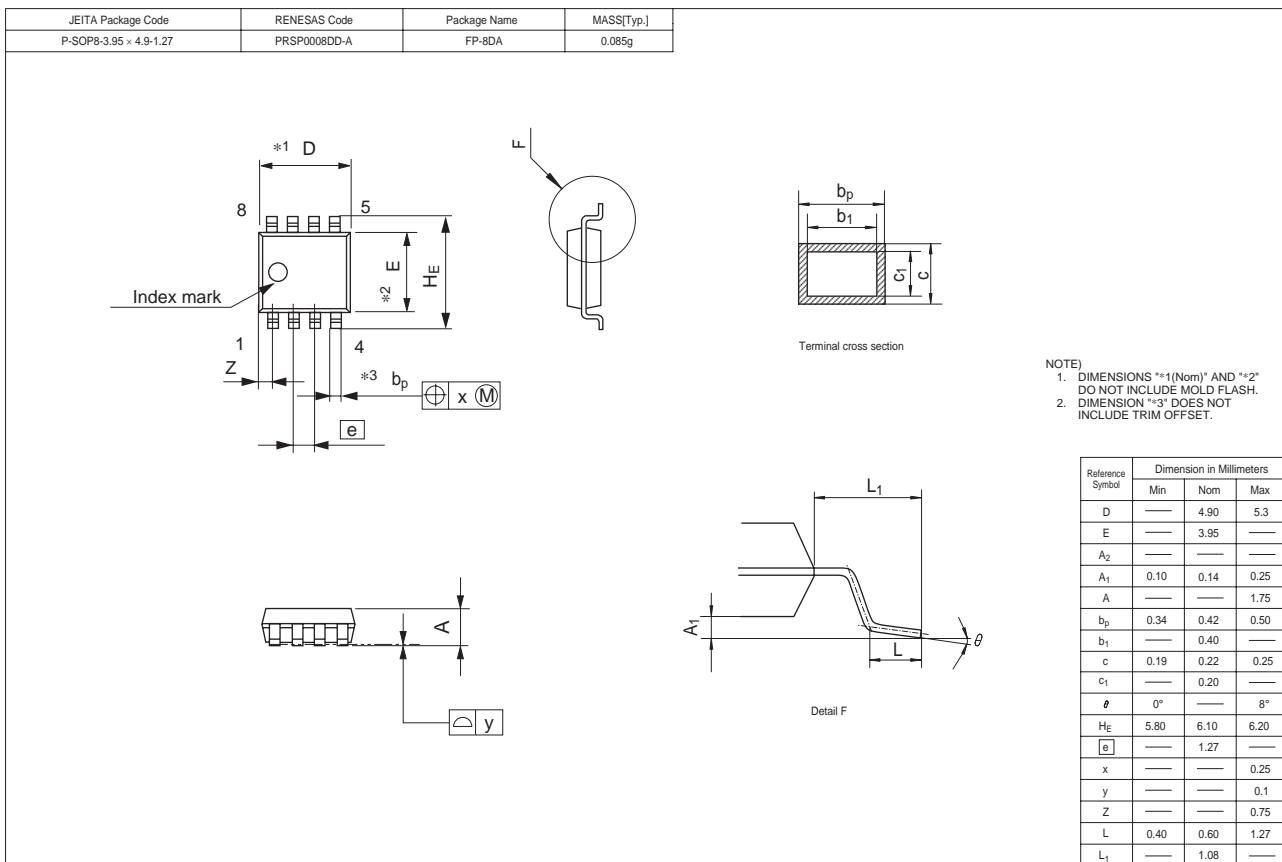




- Common



## Package Dimensions



## Ordering Information

| Part Name      | Quantity | Shipping Container |
|----------------|----------|--------------------|
| HAT2210R-EL-E  | 2500 pcs | Taping             |
| HAT2210RJ-EL-E | 2500 pcs | Taping             |

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